# CREE ᆃ

# C3M0075120J

# Silicon Carbide Power MOSFET C3M<sup>™</sup> MOSFET Technology

N-Channel Enhancement Mode

### Features

- 3rd generation SiC MOSFET technology
- Low impedance package with driver source pin
- 7mm of creepage distance between drain and source
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery  $(Q_{rr})$
- Halogen free, RoHS compliant

#### **Benefits**

• Reduce switching losses and minimize gate ringing

Maximum Ratings (T<sub>c</sub> = 25 °C unless otherwise specified)

- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

#### Applications

- Renewable energy
- EV battery chargers
- High voltage DC/DC converters
- Switch Mode Power Supplies

Part Number	Package	Marking	
C3M0075120J	TO-263-7	C3M0075120J	

Symbol	Parameter	Value	Unit	Test Conditions	Note
$V_{\text{DSmax}}$	Drain - Source Voltage	1200	V	$V_{GS} = 0 \text{ V, } I_{D} = 100 \ \mu\text{A}$	
$V_{\text{GSmax}}$	Gate - Source Voltage (dynamic)	-8/+19	V	AC (f >1 Hz)	Note: 1
$V_{\text{GSop}}$	Gate - Source Voltage (static)	-4/+15	V	Static	Note: 2
I <sub>D</sub> (	Continuous Drain Current	30	А	V <sub>GS</sub> = 15 V, T <sub>C</sub> = 25°C	Fig. 19
		19.7		V <sub>GS</sub> = 15 V, T <sub>C</sub> = 100°C	
I <sub>D(pulse)</sub>	Pulsed Drain Current	80	А	Pulse width $t_P$ limited by $T_{jmax}$	Fig. 22
$P_{D}$	Power Dissipation	113.6	W	T <sub>c</sub> =25°C, T <sub>J</sub> = 150 °C	Fig. 20
$T_{J}$ , $T_{stg}$	Operating Junction and Storage Temperature	-55 to +150	°C		
TL	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s	

Note (1): When using MOSFET Body Diode V<sub>GSmax</sub> = -4V/+19V Note (2): MOSFET can also safely operate at 0/+15 V

## Package



 $\mathbf{V}_{\rm ds}$ 

I<sub>D</sub> @ 25°C

 $\mathbf{R}_{\mathsf{DS(on)}}$ 

1200 V

30 A

75 mΩ



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<b>Electrical Characteristics</b>	$(T_c = 25^{\circ}C \text{ unless otherwise specified})$
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Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note	
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	1200		1	V	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 100 μA		
	1.8	2.5	3.6	V	$V_{DS} = V_{GS}$ , $I_D = 5$ mA	<b>Fig. 11</b>		
V <sub>GS(th)</sub> Gate Threshold Voltage			2.2		V	$V_{DS} = V_{GS}$ , $I_{D} = 5$ mA, $T_{J} = 150$ °C	Fig. 11	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current		1	50	μA	$V_{DS}$ = 1200 V, $V_{GS}$ = 0 V		
I <sub>GSS</sub>	Gate-Source Leakage Current		10	250	nA	V <sub>GS</sub> = 15 V, V <sub>DS</sub> = 0 V		
D	Drain-Source On-State Resistance		75	90	mΩ	V <sub>GS</sub> = 15 V, I <sub>D</sub> = 20 A	Fig. 4,	
R <sub>DS(on)</sub>			100		11152	$V_{GS}$ = 15 V, I <sub>D</sub> = 20A, T <sub>J</sub> = 150°C	5, 6	
G.	Transconductance		12		S	V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 20 A	— Fig. 7	
<b>g</b> <sub>fs</sub>	Transconductance		13		3	V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 20 A, T <sub>J</sub> = 150°C		
$C_{\text{iss}}$	Input Capacitance		1390				Fig. 17, 18	
$C_{\text{oss}}$	Output Capacitance		58	Ì	рF	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1000 V		
$C_{rss}$	Reverse Transfer Capacitance		2			f = 1 MHz Vac = 25 mV		
E <sub>oss</sub>	Coss Stored Energy		33		μJ		Fig. 16	
Eon	Turn-On Switching Energy (Body Diode FWD)		200			V <sub>DS</sub> = 800 V, V <sub>GS</sub> = -4 V/15 V, I <sub>D</sub> = 20A,	Fig. 26, 29	
EOFF	Turn-Off Switching Energy (Body Diode FWD)		90	1	μJ	$R_{G(ext)}$ = 0 Ω, L= 156 μH, T <sub>J</sub> = 150°C		
$t_{\text{d(on)}}$	Turn-On Delay Time		7				Fig. 27, 28, 29	
tr	Rise Time		15					
$t_{\text{d(off)}}$	Turn-Off Delay Time		24		ns	Timing relative to V <sub>DS</sub> Inductive load		
t <sub>f</sub>	Fall Time		8		1			
R <sub>G(int)</sub>	Internal Gate Resistance		9		Ω	f = 1 MHz, V <sub>AC</sub> = 25 mV		
$Q_{gs}$	Gate to Source Charge		18			V <sub>DS</sub> = 800 V, V <sub>GS</sub> = -4 V/15 V	, Fig. 12	
$Q_{gd}$	Gate to Drain Charge		12	]	nC	I <sub>D</sub> = 20 A		
Qg	Total Gate Charge		48			Per IEC60747-8-4 pg 21		

Reverse Diode Characteristics (T<sub>c</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
		4.5		V	V <sub>GS</sub> = -4 V, I <sub>SD</sub> = 10 A	Fig. 8,
V <sub>SD</sub>	Diode Forward Voltage	4.0		V	V <sub>GS</sub> = -4 V, I <sub>SD</sub> = 10 A, T <sub>J</sub> = 150 °C	9,10
Is	Continuous Diode Forward Current		22.4	А	$V_{gg} = -4 V$	Note 1
I <sub>S, pulse</sub>	Diode pulse Current	80		А	$V_{GS}$ = -4 V, pulse width t <sub>P</sub> limited by T <sub>jmax</sub>	Note 1
t <sub>rr</sub>	Reverse Recover time	25		ns		
Q <sub>rr</sub>	Reverse Recovery Charge	109		nC	V <sub>GS</sub> = -4 V, I <sub>SD</sub> = 20 A, V <sub>R</sub> = 800 V dif/dt = 1925 A/µs, T <sub>J</sub> = 25 °C	Note 1, Fig. 29
I <sub>rrm</sub>	Peak Reverse Recovery Current	11		А	•••	

#### **Thermal Characteristics**

Symbol Parameter		Max.	Unit	Test Conditions	Note
R <sub>0JC</sub>	Thermal Resistance from Junction to Case	1.1			<b>Fig. 01</b>
R <sub>0JA</sub>	R <sub>8JA</sub> Thermal Resistance From Junction to Ambient		°C/W		Fig. 21





Figure 1. Output Characteristics T<sub>J</sub> = -55 °C



Figure 3. Output Characteristics T<sub>J</sub> = 150 °C







Figure 2. Output Characteristics T<sub>J</sub> = 25 °C













Figure 11. Threshold Voltage vs. Temperature

Figure 12. Gate Charge Characteristics





Figure 13. 3rd Quadrant Characteristic at -55 °C



Figure 15. 3rd Quadrant Characteristic at 150 °C







Figure 14. 3rd Quadrant Characteristic at 25 °C



Figure 16. Output Capacitor Stored Energy



Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1000V)































Figure 25. Clamped Inductive Switching Energy vs.  $R_{G(ext)}$ 



Figure 27. Switching Times vs. R<sub>G(ext)</sub>



Figure 26. Clamped Inductive Switching Energy vs. Temperature



Figure 28. Switching Times Definition



Test Circuit Schematic



Figure 29. Clamped Inductive Switching Waveform Test Circuit

Note (3): Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET Body Diode as shown above.

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# Package Dimensions

Package 7L D2PAK



Dim	All Dimensions in Millimeters							
DIM	Min	typ	Max					
А	4.300	4.435	4.570					
A1	0.00	0.125	0.25					
b	0.500	0.600	0.700					
b2	0.600	0.800	1.000					
с	0.330	0.490	0.650					
C2	1.170	1.285	1.400					
D	9.025	9.075	9.125					
D1	4.700	4.800	4.900					
E	10.130	10.180	10.230					
E1	6.500	7.550	8.600					
E2	6.778	7.223	7.665					
е		1.27						
Н	15.043	16.178	17.313					
L	2.324	2.512	2.700					
L1	0.968	1.418	1.868					
Ø	0°	4°	8°					
Ø1	4.5°	5°	5.5°					





#### **Notes**

#### RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/ EC (RoHS2), as implemented January 2, 2013. RoHS Declarations for this product can be obtained from your Cree representative or from the Product Documentation sections of www.cree.com.

#### REACh Compliance

REACh substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a Cree representative to insure you get the most up-to-date REACh SVHC Declaration. REACh banned substance information (REACh Article 67) is also available upon request.

This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, air traffic control systems.

#### **Related Links**

- SPICE Models: http://wolfspeed.com/power/tools-and-support
- SiC MOSFET Isolated Gate Driver reference design: http://wolfspeed.com/power/tools-and-support
- SiC MOSFET Evaluation Board: http://wolfspeed.com/power/tools-and-support

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